Search Notes

Application/Control No.	Applicant(s)/Patent under . Reexamination	
10/784,996	TAI ET AL.	
Examiner	Art Unit	

1756

John A. McPherson

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
•	DATE	EXMR		
430/259,260, 270.1, 281.1, 286.1 (updated text search) - see search history printout	2/7/2007	JAM		
EAST (USPAT, USPGPUB, JPO, EPO, DERWENT, IBM TDB) - see search history printout	2/7/2007	JAM		
eDAN inventor search	2/8/2007	JAM		
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